

Notice of References Cited

Application/Control No.

10/039,836

Applicant(s)/Patent Under
Reexamination
CRANE ET AL.

Examiner

Anne R. Kubelik

Art Unit

1638

Page 1 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,462,257	10-2002	Perera et al.	800/287
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Maiti et al, 1997, Transgen. Res., 6:143-156)
	V	Doelling et al, 1995, Plant J. 8:683-692)
	W	Donald et al, 1990, EMBO J. 9:1717-1726
	X	Chen et al, 2000, Sex. Plant Reprod. 13:85-94

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited

Application/Control No.

10/039,836

Applicant(s)/Patent Under
Reexamination
CRANE ET AL.

Examiner

Anne R. Kubelik

Art Unit

1638

Page 2 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Benfrey et al, 1990, Science 250:959-966
	V	Kim et al, 1994, Plant Mol. Biol. 24:105-117
	W	
	X	

*A copy of this reference is not being furnished with this Office action (See MPEP § 707 05(a))
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.